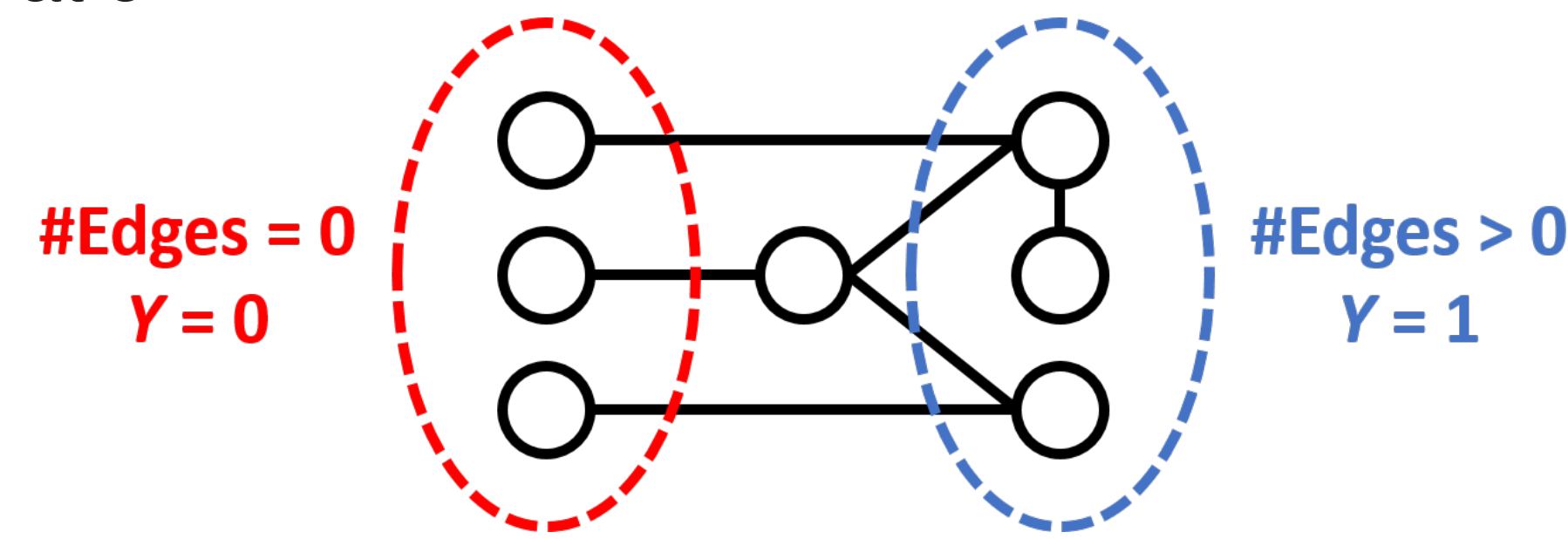


## Problem Setup

- **Goal.** Learn a graph  $G = (V, E)$  via *edge detecting queries*:

$$Y = \bigvee_{(i,j) \in E} \{\text{nodes } i \text{ and } j \text{ included in the test}\}$$

An illustration:



- Potential applications: Learning chemical interactions, wireless connectivity, social networks with privacy constraints, etc.

- **Erdős-Rényi model:** Each edge appears independently with probability  $q$  (in this work,  $q \ll 1$ )

- **Error probability:** If the estimated graph is  $\hat{G}$ , then

$$\Pr[\text{error}] := \mathbb{P}[\hat{G} \neq G].$$

- **Sparsity level**

- Let  $n$  denote the number of nodes  
► We consider the sparse regime  $q = \Theta(n^{-2(1-\theta)})$  with  $\theta \in (0, 1)$   
► Average number of edges:  $\bar{k} = \binom{n}{2}q = \Theta(n^{2\theta})$

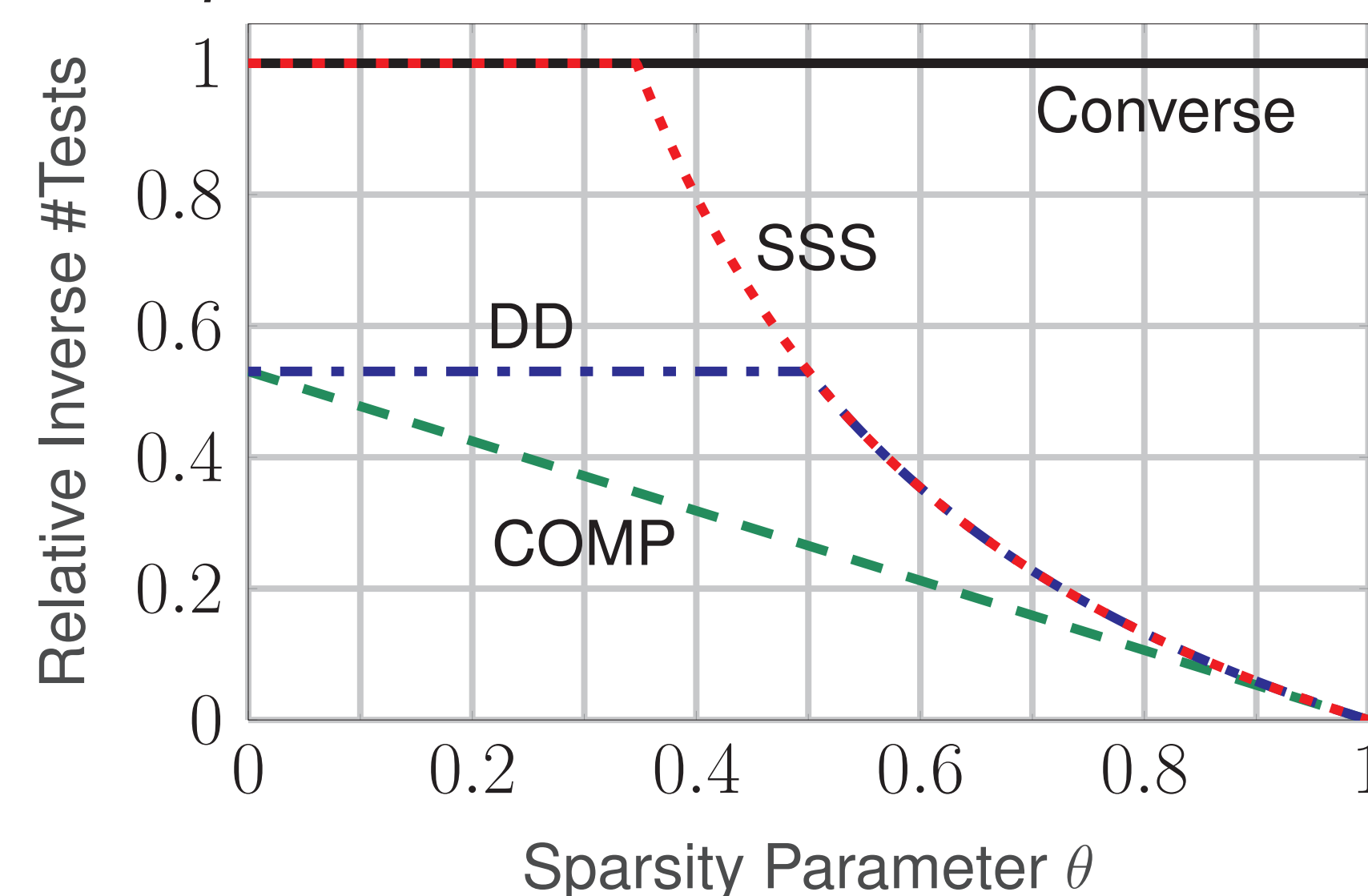
- **Bernoulli random testing:** Each node is independently placed in each test with probability  $p = \frac{\nu}{k}$  for some  $\nu > 0$

## Contributions

- **Existing hardness result [1]:** Learning an arbitrary graph with  $n$  nodes and  $k$  edges requires  $\Omega(\min\{k^2 \log n, n^2\})$  tests

- **This work:** Learning an Erdős-Rényi random graph with an average of  $\bar{k}$  edges only requires  $O(\bar{k} \log n)$  tests

- *Explicit near-optimal constant factors:*



## Algorithm-Independent Lower Bound

**Theorem 1.** If the number of tests satisfies

$$\# \text{Tests} \leq \left( \bar{k} \log_2 \frac{1}{q} \right) (1 - o(1))$$

as  $n \rightarrow \infty$ , then it is impossible for any algorithm (and test design) to achieve  $\Pr[\text{error}] \rightarrow 0$ .

## Algorithmic Upper Bounds

- **COMP Algorithm:**

- Initialize  $\hat{E}$  to contain all  $\binom{n}{2}$  edges
- For each negative test, remove all edges from  $\hat{E}$  whose nodes are both included in the test
- Output  $\hat{G} = (V, \hat{E})$

**Theorem 2.** The COMP algorithm achieves  $\Pr[\text{error}] \rightarrow 0$  as  $n \rightarrow \infty$  as long as

$$\# \text{Tests} \geq (2e \cdot \bar{k} \log n)(1 + o(1))$$

- **DD Algorithm:**

- Initialize  $\hat{E} = \emptyset$ , and initialize PE to contain all  $\binom{n}{2}$  edges
- For each negative test, remove all edges from PE whose nodes are both included in the test
- For each positive test, if the test covers exactly one edge in PE (the set of *possible edges*), add that edge to  $\hat{E}$
- Output  $\hat{G} = (V, \hat{E})$

**Theorem 3.** The DD algorithm achieves  $\Pr[\text{error}] \rightarrow 0$  as  $n \rightarrow \infty$  as long as

$$\# \text{Tests} \geq (2 \max\{\theta, 1 - \theta\} e \cdot \bar{k} \log n)(1 + o(1))$$

## SSS Algorithm Lower Bound

**SSS Algorithm:** Using integer programming, find the graph with the fewest edges that is consistent with the test results

**Theorem 4.** The (essentially optimal) SSS algorithm yields  $\Pr[\text{error}] \rightarrow 1$  as  $n \rightarrow \infty$  as long as

$$\# \text{Tests} \leq (2\theta e \cdot \bar{k} \log n)(1 - o(1)).$$

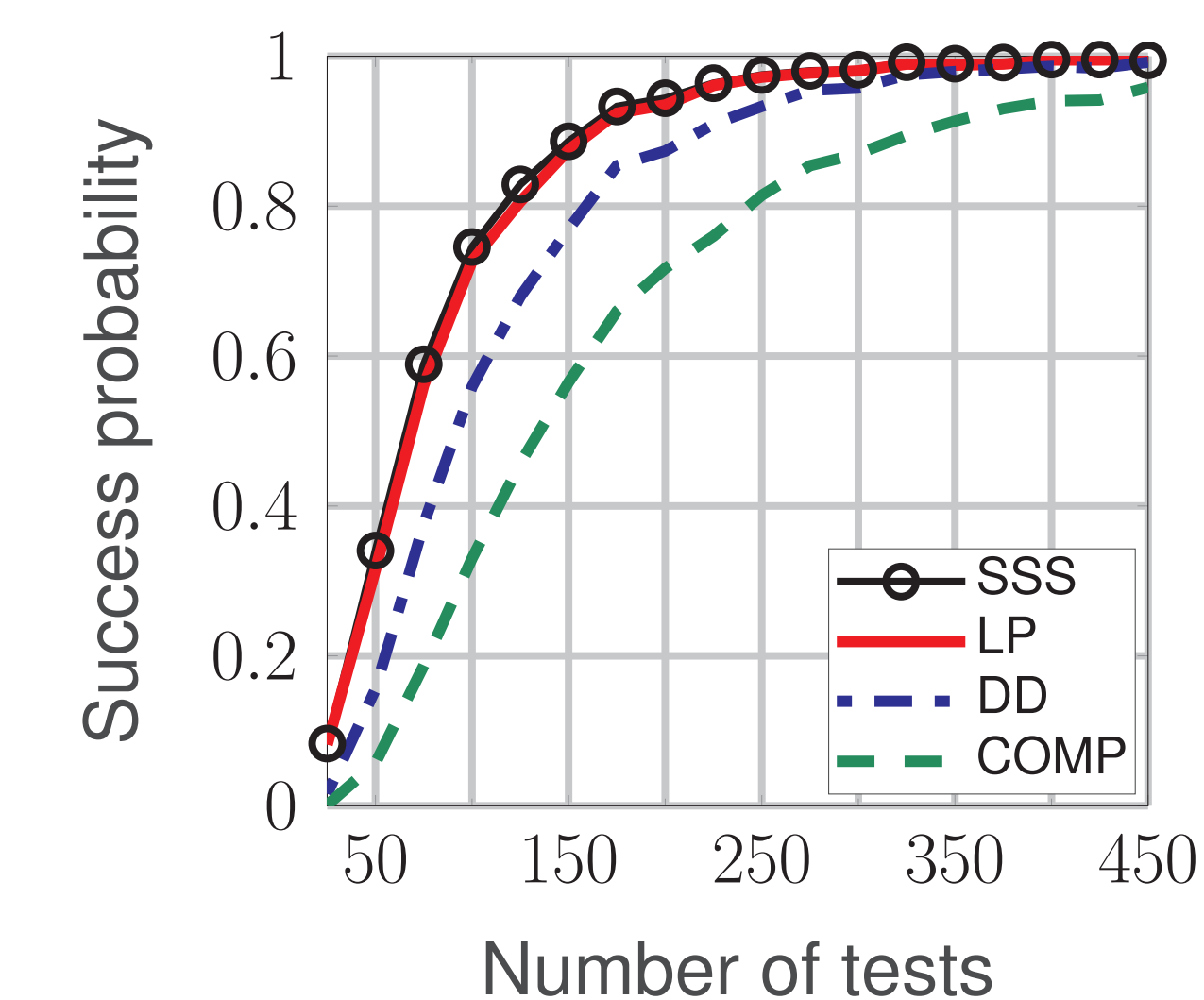
## Sublinear-Time Decoding

**Group Testing Quick and Efficient (GROTESQUE):**

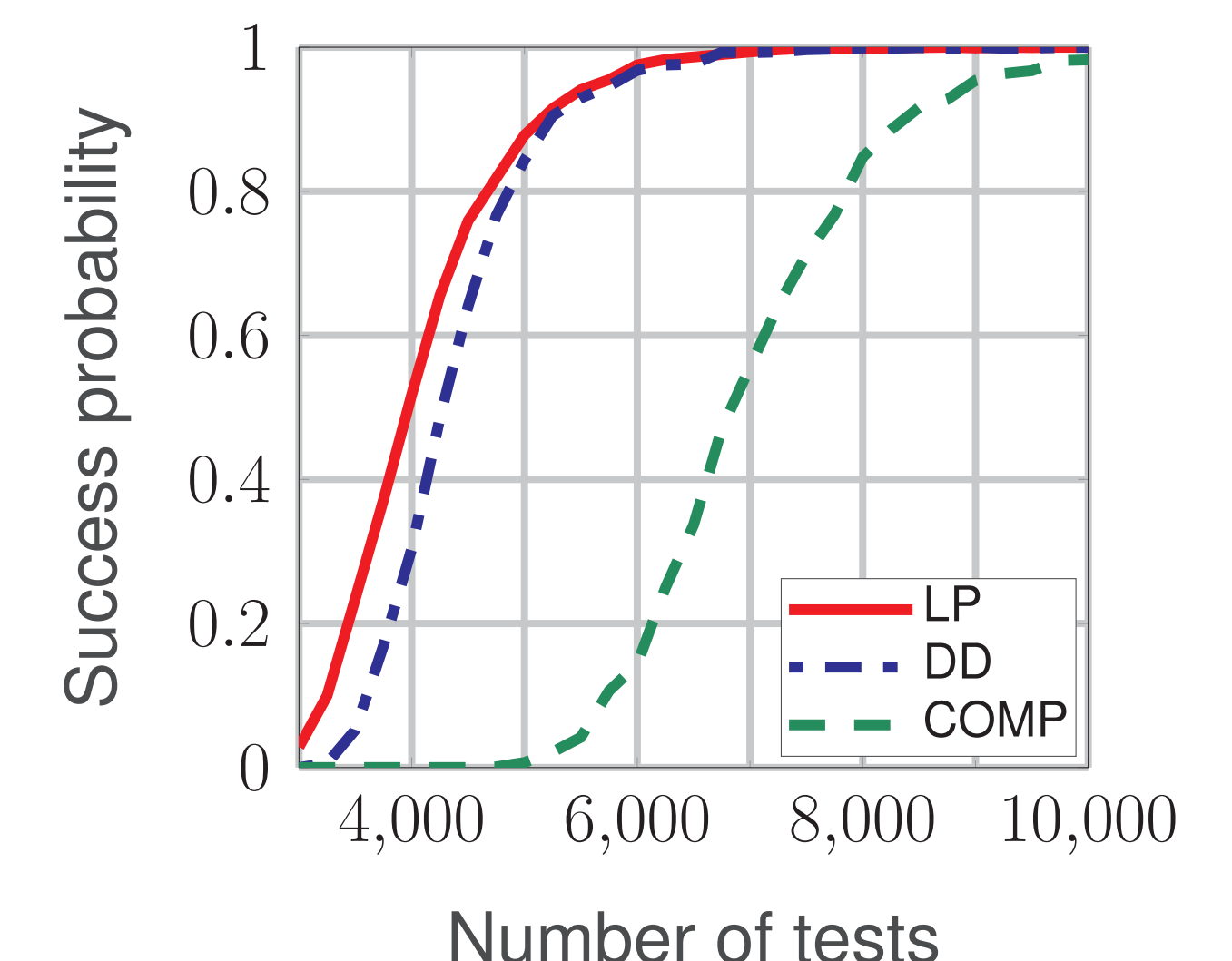
- Form  $O(\bar{k} \log \bar{k})$  random bundles of nodes
- Use *multiplicity tests* to find bundles with exactly one edge
- Use *location tests* to determine those edges

**Theorem 5.** The GROTESQUE test design and decoding algorithm achieves  $\Pr[\text{error}] \rightarrow 0$  with  $t = O(\bar{k} \cdot \log \bar{k} \cdot \log^2 n)$  tests, and has  $O(\bar{k} \log^2 \bar{k} + \bar{k} \log n)$  decoding time

## Numerical Experiments



(i)  $n = 50$ ,  $\bar{k} = 5$  and  $\nu = 1$



(ii)  $n = 200$ ,  $\bar{k} = 200$  and  $\nu = 1$

## References

- [1] H. Abasi and N. H. Bshouty, "On learning graphs with edge-detecting queries," 2018, <https://arxiv.org/abs/1803.10639>.
- [2] M. Aldridge, L. Baldassini, and O. Johnson, "Group testing algorithms: Bounds and simulations," *IEEE Trans. Inf. Theory*, vol. 60, no. 6, pp. 3671–3687, June 2014.
- [3] M. Aldridge, "The capacity of Bernoulli nonadaptive group testing," *IEEE Trans. Inf. Theory*, vol. 63, no. 11, pp. 7142–7148, 2017.
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- [5] S. Cai, M. Jahangoshahi, M. Bakshi, and S. Jaggi, "Efficient algorithms for noisy group testing," *IEEE Trans. Inf. Theory*, vol. 63, no. 4, pp. 2113–2136, 2017.

## Full Paper

<https://arxiv.org/abs/1905.03410>